

Notice of References Cited	Application/Control No. 10/533,713	Applicant(s)/Patent Under Reexamination VAN SCHIJNDEL ET AL.	
	Examiner Anna L. Verderame	Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0187272	10-2003	Shimizu et al.	548/101
*	C	US-2001/0005350	06-2001	Kitaura et al.	369/94
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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